Supporting Information for

Nanocomposite Phosphor Consisting of CaI₂:Eu²⁺ Single Nanocrystals Embedded in Crystalline SiO₂

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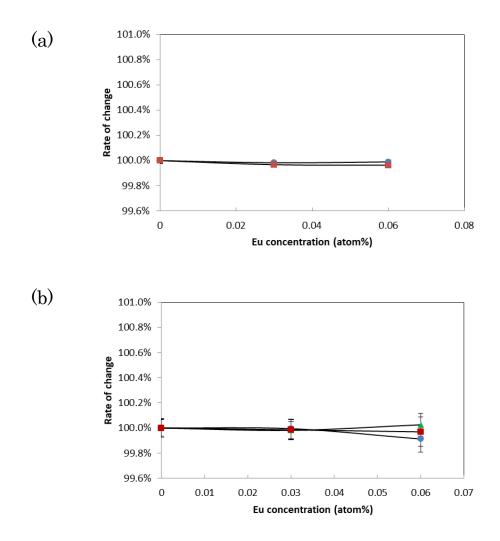


Figure S1. (a) Normalized lattice parameters against α-cristobalite in (CaI₂:Eu²⁺/SiO₂) (Eu=0) along the a-axis (blue circles) and c-axis (red squares) of α-cristobalite as a function of Eu content. (b) Normalized lattice parameters against α-CaSiO₃ in (CaI₂:Eu²⁺/SiO₂) (Eu=0) along the a-axis (blue circles), b-axis (green triangles), and c-axis (red squares) of α-CaSiO₃ as a function of Eu content. Eu atom% in (CaI₂:Eu²⁺/SiO₂) were determined with inductively coupled plasma atomic emission spectroscopy.

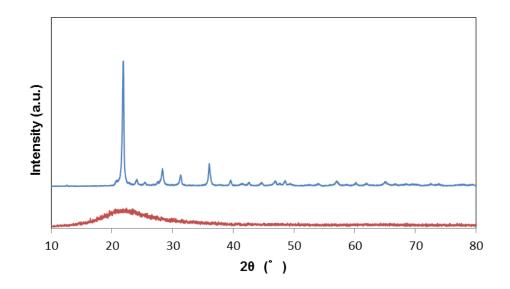


Figure S2. XRD patterns of $(CaI_2:Eu^{2+}/SiO_2)$ at sintering temperature of 1273 K (blue curve) and 1073 K (red curve).

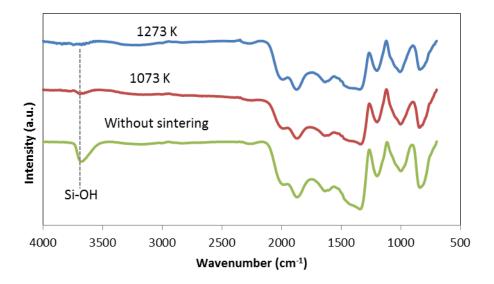


Figure S3. Fourier transform IR spectra of unsintered SiO₂ (green curve) and SiO₂ sintered at

1273 K (blue curve) and 1073 K (red curve) in a reducing atmosphere.

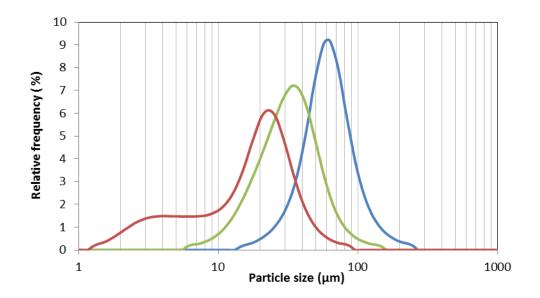


Figure S4. Particle size distribution curves of the SiO_2 raw material (green), the milled raw

materials before sintering (red), and (CaI_2:Eu $^{2+}$ /SiO₂) (blue).

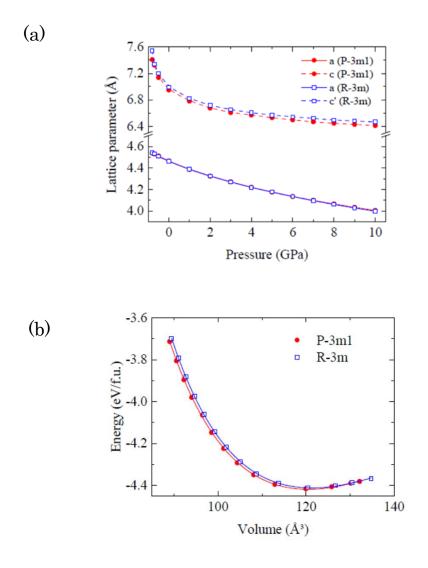


Figure S5. (a) Plots of lattice parameters as a function of external pressure: lattice parameter along the a-axis of 6H-CaI₂ (space group R3m), 1/3 of the lattice parameter along the c-axis of 6H-CaI₂ (R3m), lattice parameter along the a-axis of 2H-CaI₂ (space group P3m1), and lattice parameter along the c-axis of 2H-CaI₂ (P3m1). (b) Plots of total electron energy as a function of cell volume: 6H-CaI₂ (R3m) and 2H-CaI₂ (P3m1), respectively.

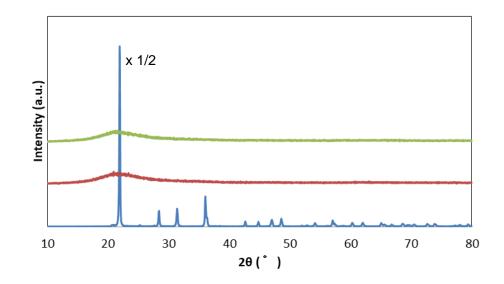


Figure S6. XRD patterns of SiO₂ powder sintered at 1273 K (green curve), 1473 K (red curve),

and 1623 K (blue curve).

	Eu	Ca	Si	Ι	Ba	Mg	Al
(CaI2:Eu2+/SiO2)	0.1	0.6	32.4	0.4	_	_	_
BaMaAl10O17:Eu2+	0.65	_	_	_	2.7	3.4	33.0

Table S1. Composition (atom %) of (CaI_2:Eu^2+/SiO_2) and BaMaAl_{10}O_{17}:Eu^{2+} measured by

inductively coupled plasma atomic emission spectroscopy combined with ion chromatography.

	Eu	Si	Ca	0	I
Nucleus at the particle center	0	33.2	0	66.5	0.3
Outer layer matrix	0	33.0	0.2	66.1	0.7
White spot in the outer layer	0.6	32.1	1.0	64.1	3.2

Table S2. Composition (atom %) of each region of the (CaI_2:Eu^2+/SiO_2) phosphor as measured by

scanning electron microscopy combined with energy dispersive X-ray spectrometry.

Table S3. Crystallographic data for 6H·CaI₂: Eu²⁺ in (CaI₂: Eu²⁺/SiO₂) by Rietveld refinement,

		<i>2H</i> -CaI ₂		
Eu atom % in (CaI2:Eu2+/SiO2)	0	0.03	0.06	_
Space group	R3 m	R3m	R3 m	P3m1
Lattice parameter				
а	4.510(2)	4.530(1)	4.548(1)	4.49(2)
с	20.998(27)	21.002(12)	21.006(15)	6.975(30)

along with literature data for 2H-CaI₂.

Eu atom% in $(CaI_2:Eu^{2+}/SiO_2)$ were determined with inductively coupled plasma atomic emission spectroscopy.